

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
60V	2.6mΩ@10V	100A
	3.5mΩ@4.5V	

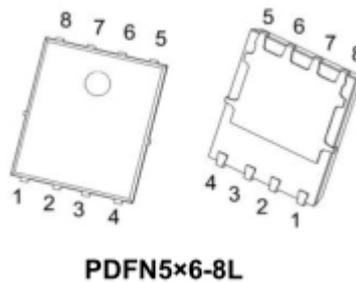
Feature

- Low $R_{DS(on)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity
- Fast switching and soft recovery

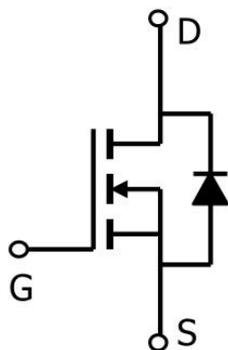
Applications

- Consumer electronic power supply
- Motor control
- Synchronous-rectification
- Isolated DC/DC convertor
- Invertors

Package



Circuit diagram



Marking



60N03G : Product code
* :Month code.

Absolute maximum ratings

($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain source voltage	V_{DS}	60	V
Gate source voltage	V_{GS}	± 20	V
Continuous drain current ¹⁾	I_D	100	A
Pulsed drain current ²⁾	I_{DM}	400	A
Power dissipation ³⁾	P_D	140	W
Single pulsed avalanche energy ⁵⁾	E_{AS}	80	mJ
Thermal resistance, junction-case	$R_{\theta JC}$	0.89	$^{\circ}\text{C}/\text{W}$
Thermal resistance, junction-ambient ⁴⁾	$R_{\theta JA}$	62	$^{\circ}\text{C}$
Operation and storage temperature	T_J, T_{STG}	-55~ +150	$^{\circ}\text{C}$

Electrical characteristics

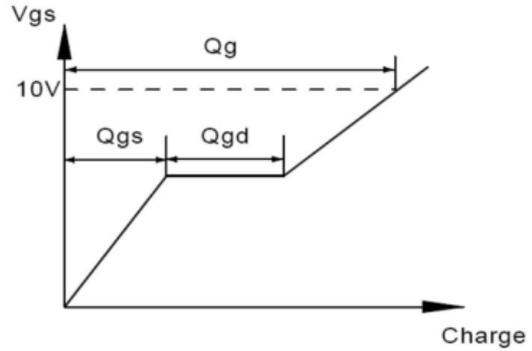
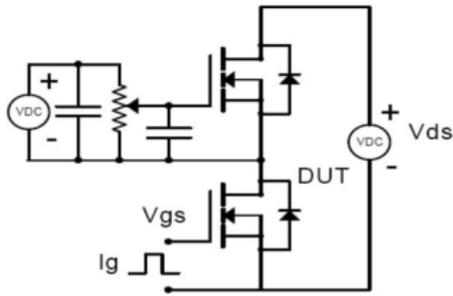
($T_A=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	$BV_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.3		2.5	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$		2.6	3.2	m Ω
		$V_{GS} = 4.5V, I_D = 10A$		3.5	4.3	
Gate-source leakage current	I_{GSS}	$V_{GS} = \pm 20V$			± 100	μA
Drain-source leakage current	I_{DSS}	$V_{DS} = 60V, V_{GS} = 0V$			1	μA
Dynamic Characteristics						
Input capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=25V,$ $f=100KHz$		5377		pF
Output capacitance	C_{oss}			1666		
Reverse transfer capacitance	C_{rss}			77.7		
Turn-on delay time	$T_{d(on)}$	$V_{GS}=10V, V_{DS}=30V,$ $R_G = 2\Omega, I_D = 25A$		22.5		nS
Rise time	T_r			6.7		
Turn-off delay time	$T_{d(off)}$			80.3		
Fall time	T_f			26.8		
Switching Characteristics						
Total Gate Charge	Q_g	$I_D = 25A, V_{DS}=30V,$ $V_{GS}=10V$		66.1		pF
Gate-Source Charge	Q_{gs}			10.7		
Gate-Drain Charge	Q_{gd}			10.9		
Gate plateau voltage	$V_{plateau}$			2.9		V
Diode Characteristics						
Diode forward voltage	V_{SD}	$V_{GS}=0V, I_S=20A$			1.3	V
Reverse recovery time	t_{rr}	$I_S=25A, di/dt=100 A/\mu s$		68.3		ns
Reverse recovery charge	Q_{rr}				73	
Peak reverse recovery current	I_{rrm}			1.9		A

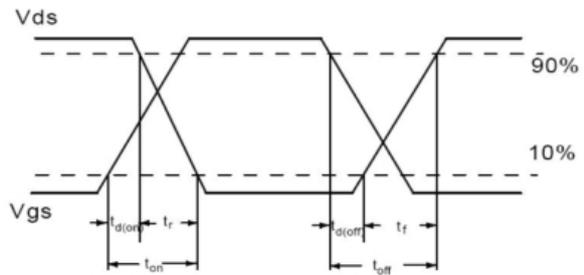
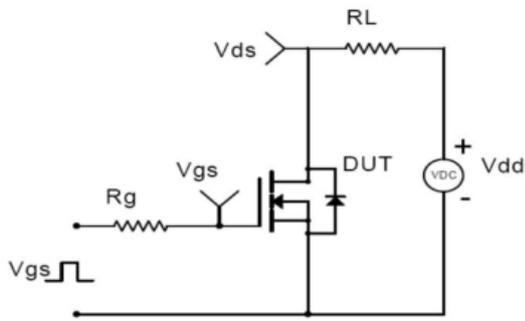
Note :

1. Calculated continuous current based on maximum allowable junction temperature.
2. Repetitive rating; pulse width limited by max. junction temperature.
3. Pd is based on max. junction temperature, using junction-case thermal resistance.
4. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_a=25^\circ\text{C}$.
5. $V_{DD}=50V, R_G=25\Omega, L=0.3mH$, starting $T_J=25^\circ\text{C}$.

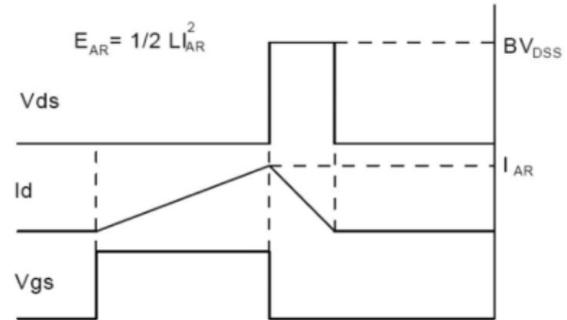
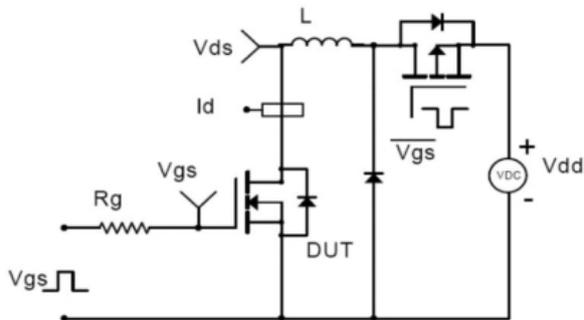
Typical Characteristics



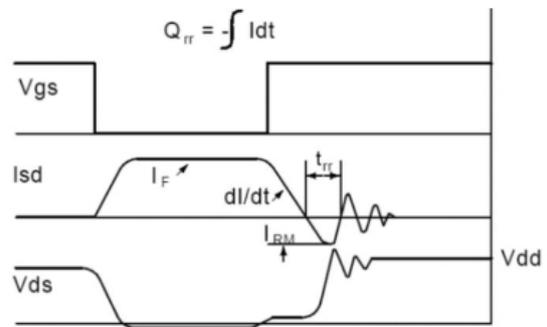
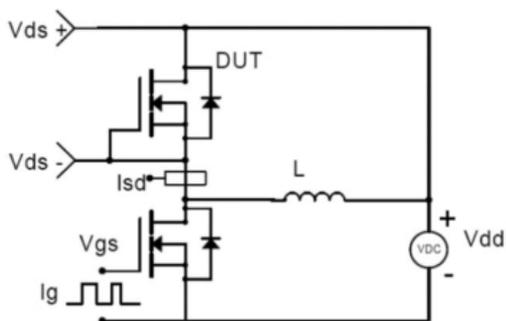
Gate charge test circuit & waveform



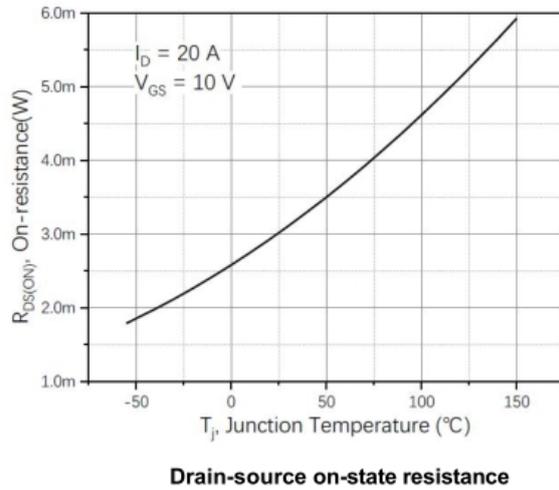
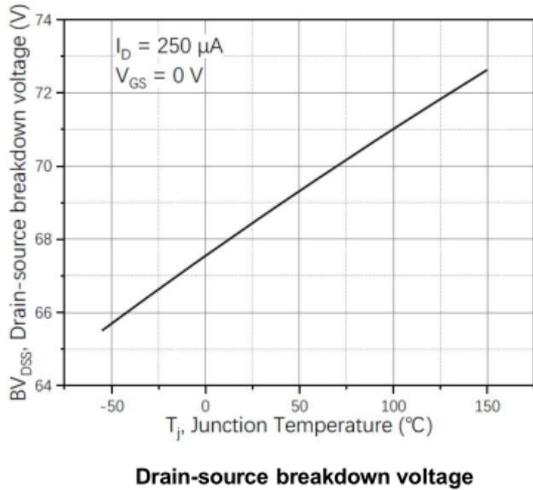
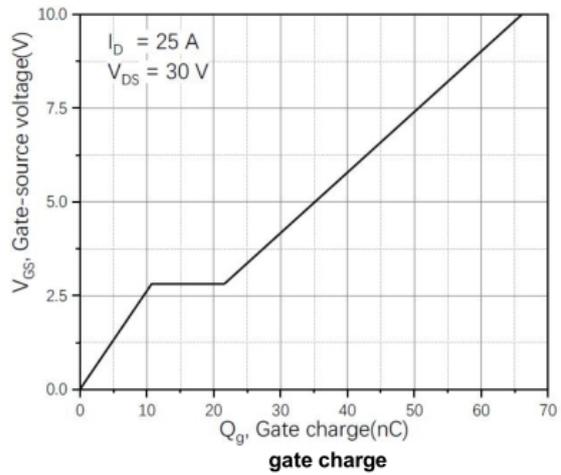
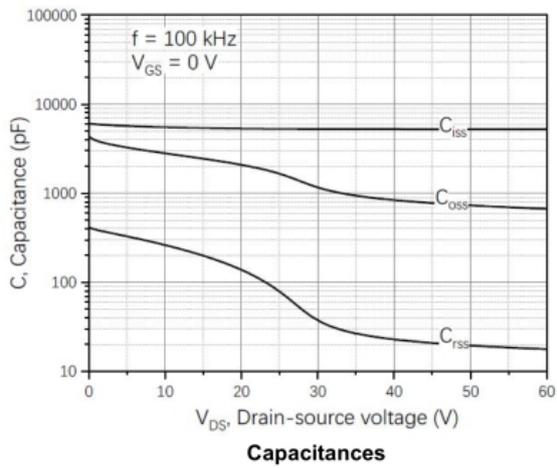
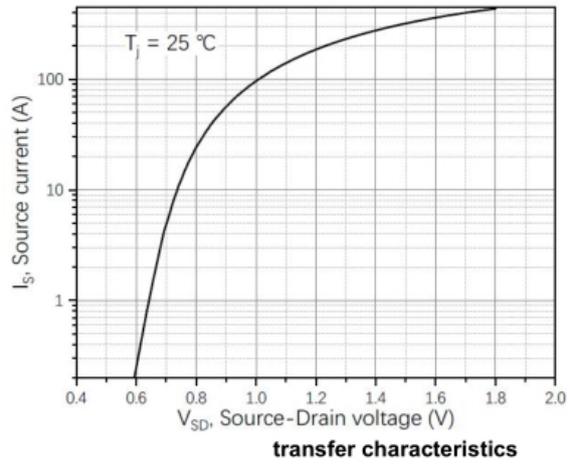
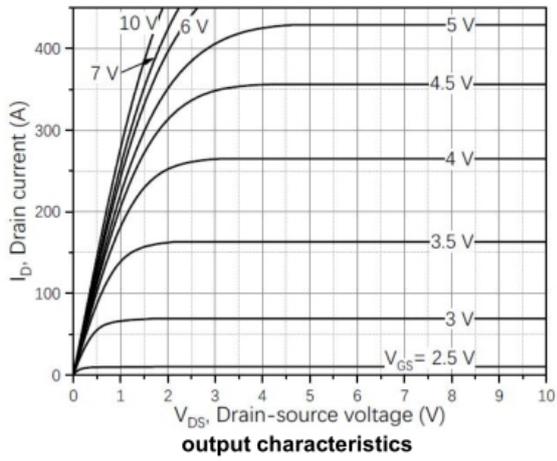
Switching time test circuit & waveforms

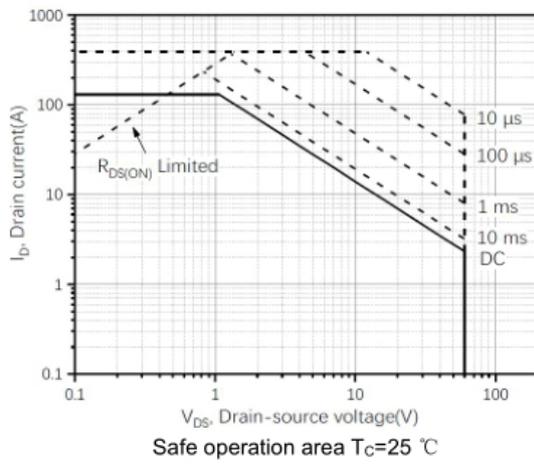
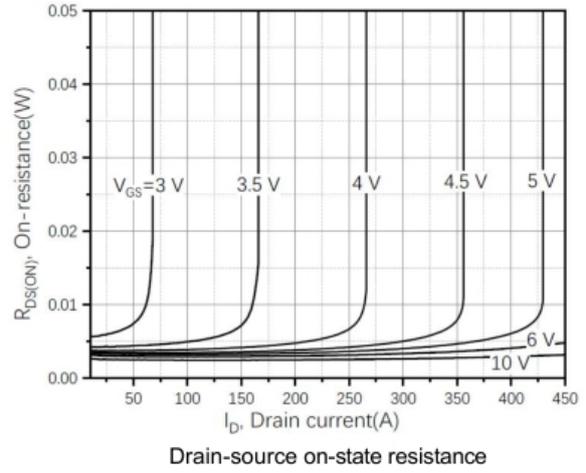
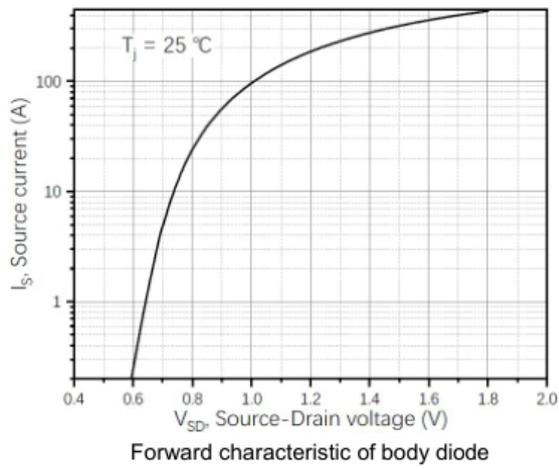


Unclamped inductive switching (UIS) test circuit & waveforms

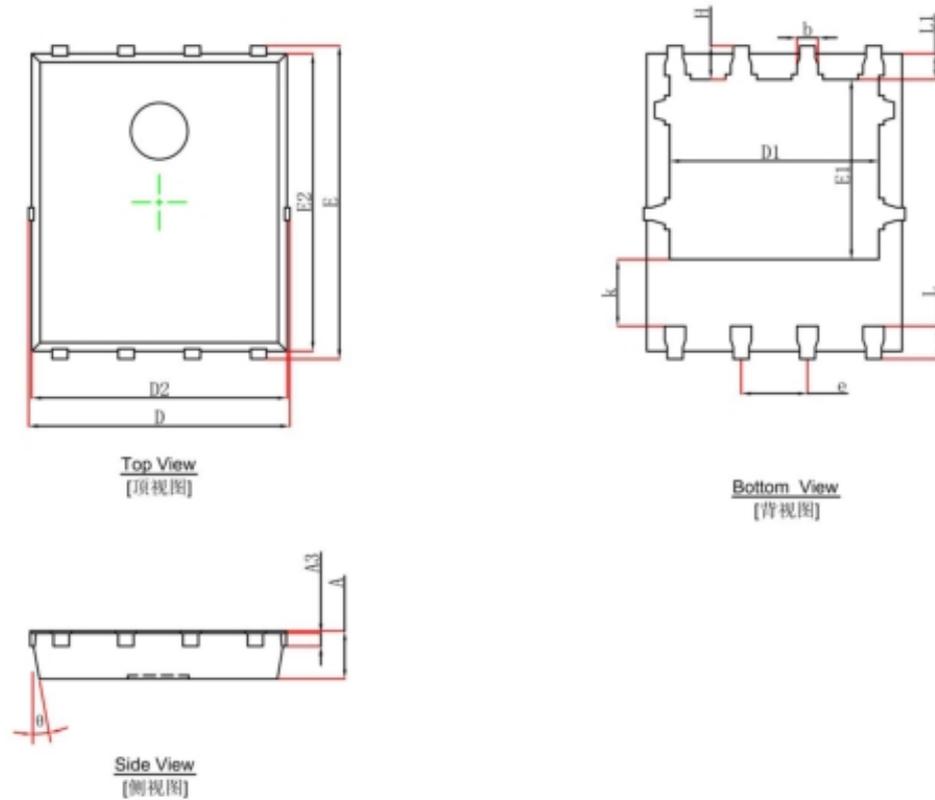


Diode reverse recovery test circuit & waveforms





PDFNWB5X6-8L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.		0.010REF.	
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°